4 G

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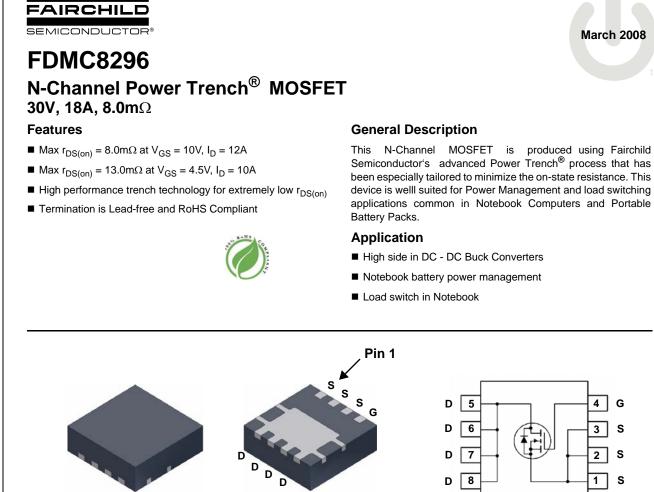
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S





Power 33



TOP

Symbol		Parar	neter		Ratings	Units		
V _{DS}	Drain to	Source Voltage			30	V		
V _{GS}	Gate to	Source Voltage			±20	V		
I _D	Drain C	urrent -Continuous (Package li	imited) $T_{\rm C} = 25$	5°C	18			
		-Continuous (Silicon limited) T _C = 25°C				٨		
		-Continuous	T _A = 25	°C (Note 1a) 12	— A		
		-Pulsed						
E _{AS}	Single F	ulse Avalanche Energy		(Note 3)) 60	mJ		
D	Power D	Dissipation	T _C = 25	5°C	27	W		
P _D Powe		Dissipation	T _A = 25	°C (Note 1a)) 2.3	VV		
T _J , T _{STG}	Operatir	Operating and Storage Junction Temperature Range		-55 to +150	°C			
Thermal Ch _{R_{θJC}}		stics Resistance, Junction to Case			4.6			
R _{θJA}	Thermal Resistance, Junction to Ambient (Note 1a)				°C/W			
	arking a	nd Ordering Information	n					
Device Ma	arking	Device	Package	Reel Size	Tape Width	Quantity		
FDMC8	296	FDMC8296	Power 33	13"	12mm	3000 units		

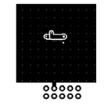
Bottom

FDMC8296 N-Channel Power Trench[®] MOSFET

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units	
Off Char	acteristics						
BV _{DSS}	Drain to Source Breakdown Voltage	I _D = 250μA, V _{GS} = 0V	30			V	
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \mu A$, referenced to 25°C		17		mV/°0	
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 24V,$ $V_{GS} = 0V,$ $T_J = 125^{\circ}C$			1 250	μA	
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$			±100	nA	
On Chara	acteristics						
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	1.0	1.9	3.0	V	
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 250 \mu A$, referenced to $25^{\circ}C$		-6		mV/°0	
r _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = 10V, I_D = 12A$		6.5	8.0	mΩ	
		$V_{GS} = 4.5V, I_D = 10A$		9.5	13.0		
		$V_{GS} = 10V, I_D = 12A, T_J = 125^{\circ}C$		9.0	12.8		
9 _{FS}	Forward Transconductance	$V_{DD} = 5V, I_D = 12A$		44		S	
C _{iss} C _{oss}	Characteristics Input Capacitance Output Capacitance	── V _{DS} = 15V, V _{GS} = 0V, ── f = 1MHz		1038 513	1385 685	pF pF	
C _{rss}	Reverse Transfer Capacitance	1 - 111112		87	135	pF	
R _g	Gate Resistance	f = 1MHz		0.9		Ω	
Switchin	g Characteristics						
t _{d(on)}	Turn-On Delay Time			9	18	ns	
t _r	Rise Time	$V_{DD} = 15V, I_D = 12A,$		3	10	ns	
t _{d(off)}	Turn-Off Delay Time	$V_{GS} = 10V, R_{GEN} = 6\Omega$		19	35	ns	
t _f	Fall Time			2	10	ns	
Q _{g(TOT)}	Total Gate Charge	$V_{GS} = 0V$ to 10V		16	23	nC	
		$V_{GS} = 0V \text{ to } 4.5V$ $V_{DD} = 15V$,		7.6	10.6	nC	
Q _{gs}	Total Gate Charge	I _D = 12A		3		nC	
Q _{gd}	Gate to Drain "Miller" Charge			2.5		nC	
neet4U.com Drain-So	urce Diode Characteristics						
V _{SD}	Source to Drain Diode Forward Voltage	$V_{GS} = 0V, I_{S} = 12A$ (Note 2)		0.82	1.3	V	
v SD	Course to Brain Blode I Urward Vollage	$V_{GS} = 0V, I_S = 1.9A$ (Note 2)		0.73	1.2	v	
00		$V_{\rm GS} = 0V, I_{\rm S} = 1.5A \qquad (1000 \text{ Z})$		0.70	1.2		
t _{rr} Q _{rr}	Reverse Recovery Time Reverse Recovery Charge	$I_{\rm F} = 12$ A, di/dt = 100A/µs		25 9	45	ns nC	

NOTES:

1. $R_{\theta JA}$ is determined with the device mounted on a 1in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



a. 53°C/W when mounted on a 1 in² pad of 2 oz copper

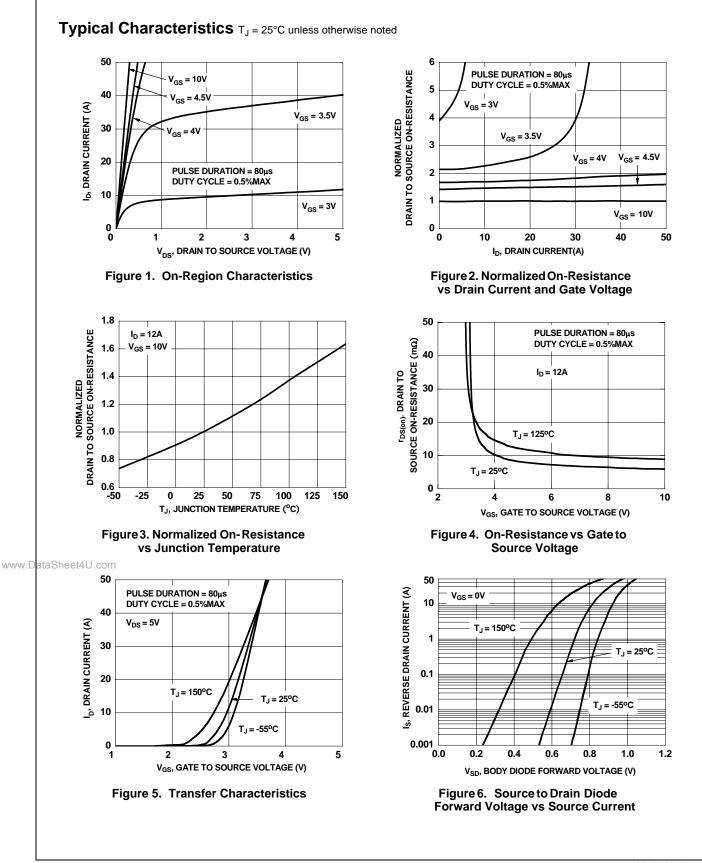


b. 125°C/W when mounted on a minimum pad of 2 oz copper

2. Pulse Test: Pulse Width < 300 μ s, Duty cycle < 2.0%.

3. Starting T_J = 25 $^{o}C;$ N-ch: L = 1 mH, I_{AS} = 11A, V_{DD} = 27V, V_{GS} = 10V.

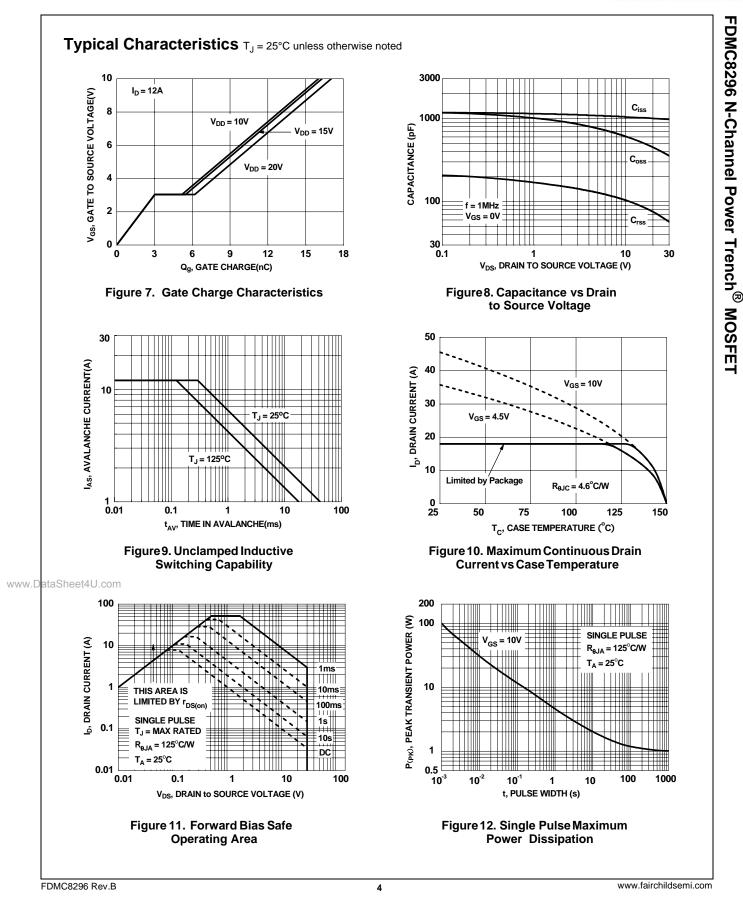
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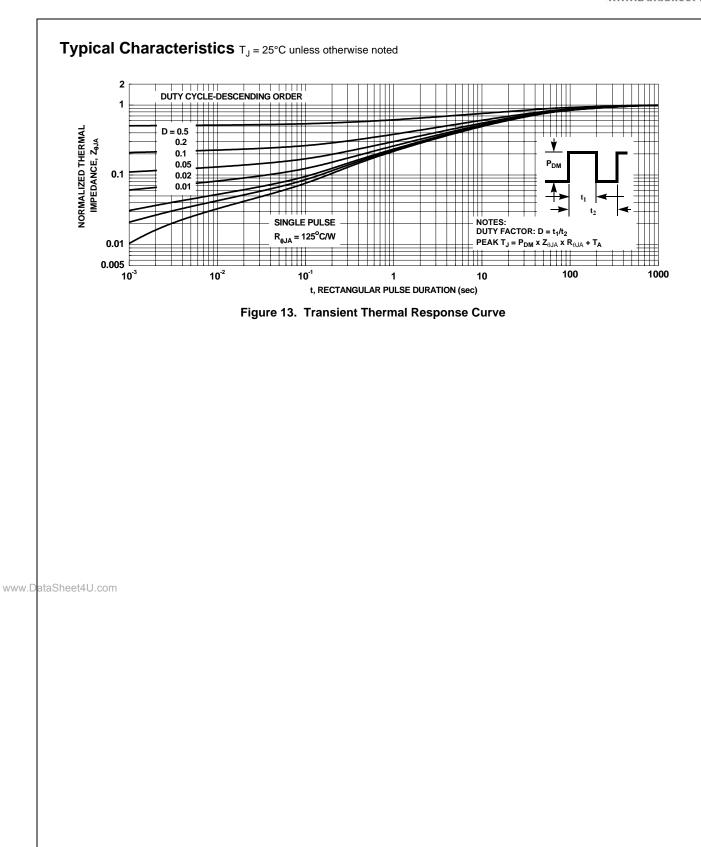
FDMC8296 Rev.B

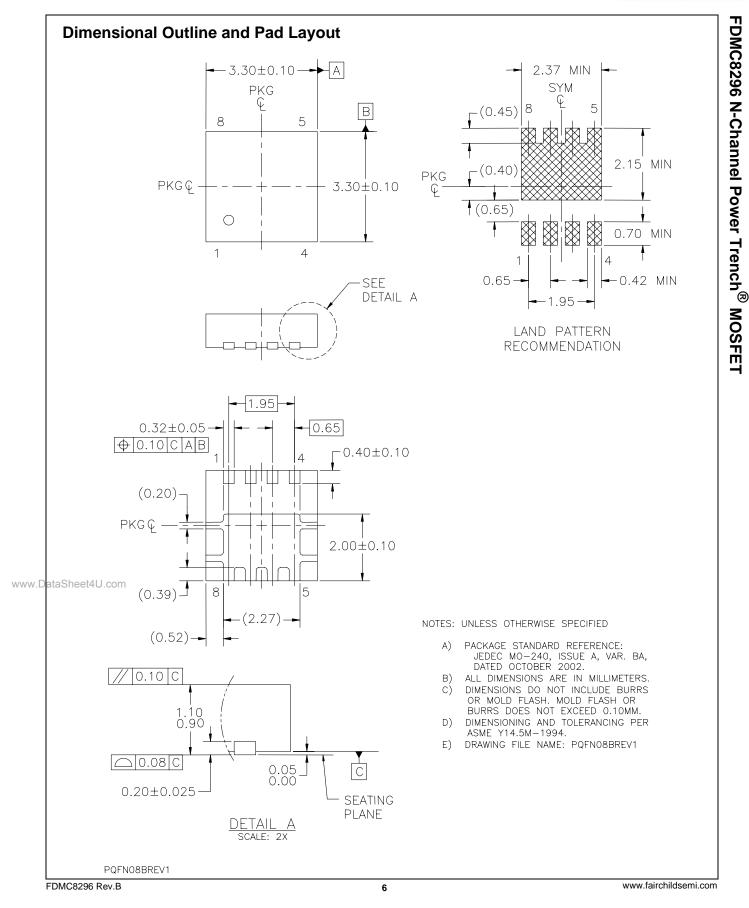
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